

<b>Notice of References Cited</b>	Application/Control No. 10/537,806		Applicant(s)/Patent Under Reexamination BOPP ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0035739	11-2001	Laig-Horstebroek et al.	320/132
*	B	US-2001/0040443	11-2001	Suzuki et al.	320/134
*	C	US-2002/0008495	01-2002	Dougherty et al.	320/104
*	D	US-2002/0070706	06-2002	Champlin, Keith S.	320/132
*	E	US-2002/0093312	07-2002	Choo, Yeon-Chul	320/149
*	F	US-2002/0101243	08-2002	Mentgen et al.	324/427
*	G	US-2002/0130637	09-2002	Schoch, Eberhard	320/132
*	H	US-2003/0030414	02-2003	Suzuki, Kouhei	320/136
*	I	US-2003/0071599	04-2003	Yoo, Chang-Hyun	320/132
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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